TOSHIBA Diodes for Protecting against ESD Epitaxial Planar Type

DF3A3.6FE

Diodes for Protecting against ESD

Unit: mm

- The mounting of two devices on an ultra-compact package allows the number of parts and the mounting cost to be reduced.
- The zener voltage corresponds to the E24 Series.

1. CATHODE1 2. CATHODE2 3. ANODE JEDEC — JEITA — TOSHIBA 1-2SA1A

Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Power dissipation	Р	100	mW
Junction temperature	Tj	125	°C
Storage temperature range	T _{stg}	-55~125	°C

Weight: 0.0023 g (typ.)

Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Zener voltage	VZ	I _Z = 5 mA	3.4	3.6	3.8	V
Dynamic impedance	Z _Z	I _Z = 5 mA	_	_	130	Ω
Reverse current	I _R	V _R = 1 V	_	_	10	μΑ
Terminal capacitance (between Cathode and Anode)	C _T	V _R = 0, f = 1 MHz		110		pF

Guaranteed Level of ESD Immunity

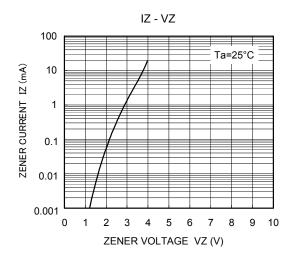
Test Condition	ESD Immunity Level
IEC61000-4-2 (Contact discharge)	± 30 kV

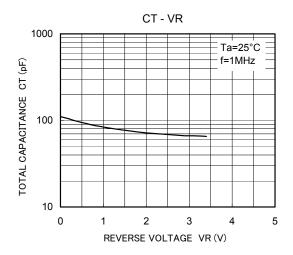
Criterion: No damage to device elements

Marking Equivalent Circuit (top view)









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